TJA1462

CAN FD signal improvement transceiver with Standby modeRev. 2 — 15 October 2021Product data sheet

1 General description

The TJA1462 is a member of the TJA146x family of transceivers that provide an interface between a Controller Area Network (CAN) or CAN FD (Flexible Data rate) protocol controller and the physical two-wire CAN bus. TJA146x transceivers implement the CAN physical layer as defined in ISO 11898-2:2016 and SAE J2284-1 to SAE J2284-5, and are fully interoperable with high-speed Classical CAN and CAN FD transceivers.

The TJA1462 includes CAN Signal Improvement Capability (SIC), as defined in CiA 601-4:2019. CAN signal improvement significantly reduces signal ringing in a network, allowing reliable CAN FD communication to function in larger topologies. In addition, the TJA1462 features a much tighter bit timing symmetry performance to enable CAN FD communication up to 8 Mbit/s.

The TJA1462 is intended as a simple replacement for high-speed Classical CAN and CAN FD transceivers, such as the TJA1042 or TJA1044GT from NXP. It offers pin compatibility and is designed to avoid changes to hardware and software design, allowing the TJA1462 to be easily retrofitted to existing applications.

An AEC-Q100 Grade 0 variant, the TJR1462, is available for high temperature applications, supporting operation at 150 °C ambient temperature.

1.1 TJA1462 variants

The TJA1462 comes in two variants, each available in an SO8 or HVSON8 package:

- The TJA1462A is a high-speed CAN transceiver with Normal and Standby modes and a VIO supply pin. The VIO pin allows for direct interfacing with 3.3 V- and 5 V-supplied microcontrollers.
- The TJA1462B is a high-speed CAN transceiver with Normal and Standby modes.

2 Features and benefits

2.1 General

- ISO 11898-2:2016, SAE J2284-1 to SAE J2284-5 and SAE J1939-14 compliant
- Implements CAN Signal Improvement Capability as defined in CiA 601-4:2019 to significantly reduce signal ringing effects in a network
- Much tighter bit timing symmetry performance allowing more time to reduce signal ringing
- Low Electromagnetic Emission (EME) and high Electromagnetic Immunity (EMI)
- Qualified according to AEC-Q100 Grade 1
- TJA1462A only: VIO input for interfacing with 3.3 V to 5 V microcontrollers
- All variants are available in SO8 and leadless HVSON8 (3.0 mm x 3.0 mm) packages; HVSON8 with improved Automated Optical Inspection (AOI) capability.



• Dark green product (halogen free and Restriction of Hazardous Substances (RoHS) compliant)

2.2 Predictable and fail-safe behavior

- Undervoltage detection with defined handling on all supply pins
- Full functionality guaranteed from the undervoltage detection thresholds up to the maximum limiting voltage values
- Defined behavior below the undervoltage detection thresholds
- Transceiver disengages from the bus (high-ohmic) when the supply voltage drops below the Off mode threshold
- Internal biasing of TXD and mode selection input pins, to enable defined fail-safe behavior

2.3 Low-power management

- · Very low-current Standby mode with host and bus wake-up capability
- TJA1462A only: CAN wake-up receiver powered by V_{IO} allowing V_{CC} to be shut down
- CAN wake-up pattern filter time of 0.5 μs to 1.8 $\mu s,$ meeting Classical CAN and CAN FD requirements

2.4 Protection

- High ESD handling capability on the bus pins (6 kV IEC and 8 kV HBM)
- Bus pins protected against transients in automotive environments
- Transmit Data (TXD) dominant time-out function
- Thermally protected

3 Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	-	5.5	V
I _{CC}	supply current	Normal mode, dominant	-	42	70	mA
		Normal mode, recessive	-	7	10	mA
		Standby mode; TJA1462A	-	-	2	μA
		Standby mode; TJA1462B	-	8	21	μA
V _{uvd(stb)(VCC)}	standby undervoltage detection voltage on pin VCC		4	-	4.5	V
V _{uvhys(stb)(VCC)}	standby undervoltage hysteresis voltage on pin VCC		50	-	-	mV
Vuvd(swoff)(VCC)	switch-off undervoltage detection voltage on pin VCC	TJA1462B	2.65	-	2.95	V
V _{IO}	supply voltage on pin VIO		2.95	-	5.5	V
I _{IO}	supply current on pin VIO	Normal mode, dominant; V _{TXD} = 0 V	-	250	760	μA
		Normal mode, recessive; $V_{TXD} = V_{IO}$	-	150	460	μA
		Standby mode	-	8	19	μA
V _{uvd(swoff)(VIO)}	switch-off undervoltage detection voltage on pin VIO		2.65	-	2.95	V
V _{ESD}	electrostatic discharge voltage	IEC 61000-4-2 on pins CANH and CANL	-6	-	+6	kV
V _{CANH}	voltage on pin CANH	limiting value according to IEC 60134	-36	-	+40	V
V _{CANL}	voltage on pin CANL	limiting value according to IEC 60134	-36	-	+40	V
T _{vj}	virtual junction temperature		-40	-	+150	°C

4 Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
TJA1462AT	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1
TJA1462BT			
TJA1462ATK HVSON8		plastic thermal enhanced very thin small outline package; no	SOT782-1
TJA1462BTK		leads; 8 terminals; body 3 × 3 × 0.85 mm	

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Table 3. TJA1462 feature overview

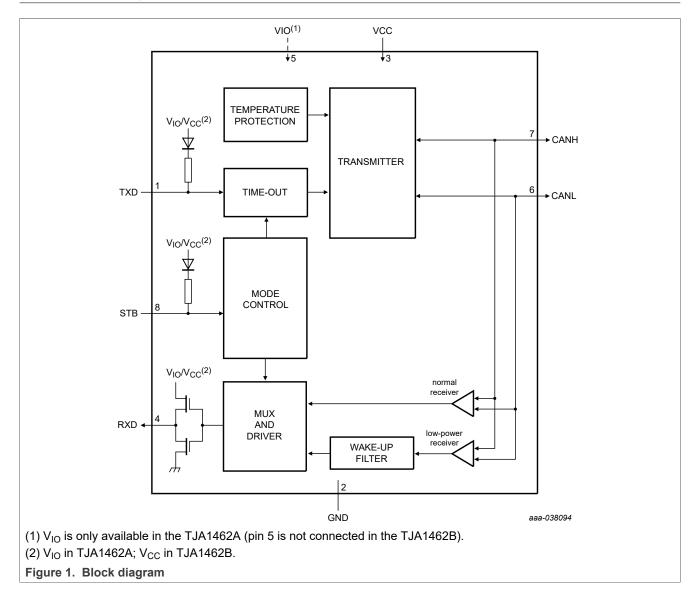
See Section 19 for a feature overview of the complete TJx144x/TJx146x/TJF1441 family.

	Mode	s				Supp	lies		Data I	rate	Addit	ional f	eatures	6		
Device ^[1]	Normal	Standby	Sleep	Silent/Listen-only	Selectable Off	VCC pin	VIO pin	VBAT pin	Up to 5 Mbit/s CAN FD	Up to 8 Mbit/s CAN FD	Signal improvement ^[2]	Wake-up source recognition ^[3]	Short WUP support [0.5 - 1.8 µs] ^[4]	Single supply pin wake-up ^[5]	TXD dominant timeout	Local diagnostics via ERR_N pin
TJA1462A	•	•				•	•		•	•	•		•	•	•	
TJx1462B	•	•				•			•	•	•		•		•	

TJA1462 is AEC-Q100 Grade 1. [1] [2] [3] [4] [5]

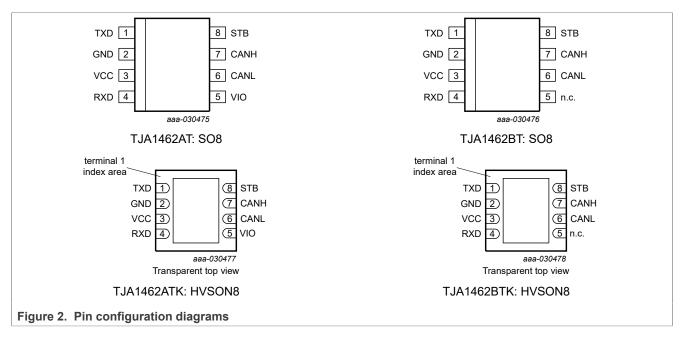
CAN FD Signal Improvement Capability (SIC) according to CiA 601-4:2019. RXD is held LOW after wake-up request, enabling wake-up source recognition. WUP = wake-up pattern according ISO11898-2:2016. Only VIO supply needed for wake-up in TJA1462A.

5 Block diagram



6 Pinning information

6.1 Pinning



6.2 Pin description

Table 4. Pin description

Symbol	Pin	Type ^[1]	Description
TXD	1	1	transmit data input; inputs data (from the CAN controller) to be written to the bus lines
GND ^[2]	2	G	ground
VCC	3	Р	5 V supply voltage input
RXD	4	0	receive data output; outputs data read from the bus lines (to the CAN controller)
VIO	5	Р	supply voltage input for I/O level adapter in TJA1462A
n.c.		-	not connected in TJA1462B
CANL	6	AIO	LOW-level CAN bus line
CANH	7	AIO	HIGH-level CAN bus line
STB	8	I	Standby mode control input; active-HIGH

[1] I: digital input; O: digital output; AIO: analog input/output; P: power supply; G: ground.

[2] HVSON package die supply ground is connected to both the GND pin and the exposed center pad. The GND pin must be soldered to board ground. For enhanced thermal and electrical performance, it is also recommended to solder the exposed center pad to board ground.

Functional description 7

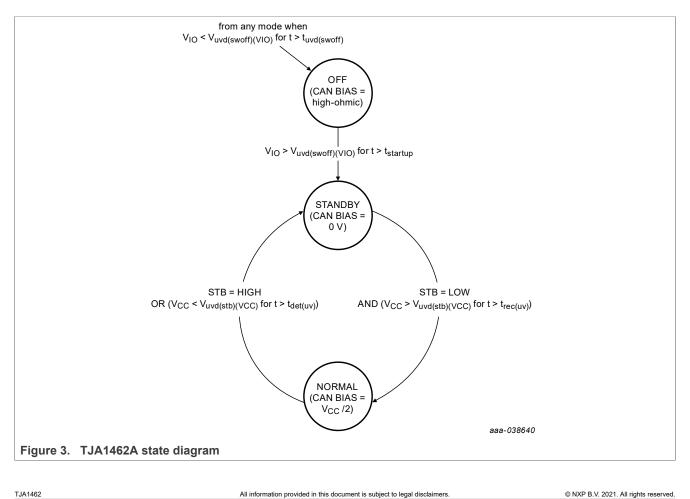
7.1 Operating modes

The TJA1462 supports three operating modes, Normal, Standby and Off. The operating mode is selected via pin STB. See Table 5 for a description of the operating modes under normal supply conditions. Mode changes are completed after transition time $t_{t(moch)}$.

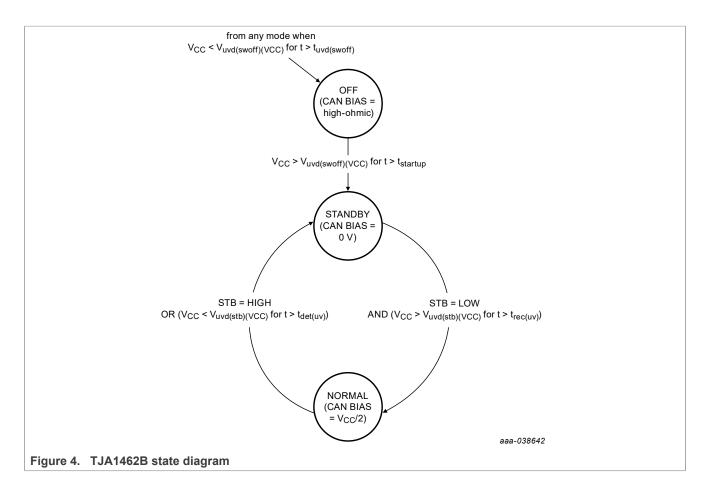
Table 5.	Operating	modes
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Mode	Inputs		Outputs				
	Pin STB	Pin TXD	CAN driver	Pin RXD			
Normal	ormal LOW L		dominant	LOW			
		HIGH	recessive	LOW when bus dominant			
				HIGH when bus recessive			
Standby	HIGH	X	biased to ground	follows BUS when wake-up detected			
				HIGH when no wake-up detected			
Off ^[1]	Off ^[1] X X high-ohmic state		high-ohmic state				

Off mode is entered when the voltage on pin VIO (TJA1462A) or pin VCC (TJA1462B) is below the switch-off undervoltage detection threshold. [1]



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7.1.1 Off mode

The TJA1462 switches to Off mode from any mode when the supply voltage (on pin VIO in the TJA1462A and VCC in the TJA1462B) falls below the switch-off undervoltage threshold ($V_{uvd(swoff)(VCC)}$ or $V_{uvd(swoff)(VIO)}$). This is the default mode when the supply is first connected.

In Off mode, the CAN pins and pin RXD are in a high-ohmic state.

7.1.2 Standby mode

When the supply voltage (V_{IO} for TJA1462A or V_{CC} for TJA1462B) rises above the switch-off undervoltage detection threshold, the TJA1462 starts to boot up, triggering an initialization procedure. The TJA1462 switches to the selected mode after $t_{startup}$.

Standby mode is selected when pin STB goes HIGH. In this mode, the transceiver is unable to transmit or receive data and a low-power receiver is activated to monitor the bus for a wake-up pattern. The transmitter and Normal-mode receiver blocks are switched off and the bus pins are biased to ground to minimize system supply current. Pin RXD follows the bus after a wake-up request has been detected.

A transition to Normal mode is triggered when STB is forced LOW (provided $V_{CC} > V_{uvd(stb)(VCC)}$ and $V_{IO} > V_{uvd(swoff)(VIO)}$ in the TJA1462A).

If V_{CC} is below $V_{uvd(stb)(VCC)}$ when STB goes LOW (with $V_{IO} > V_{uvd(swoff)(VIO)}$ in TJA1462A and $V_{CC} > V_{uvd(swoff)(VCC)}$ in TJA1462B), the TJA1462 will remain in Standby mode.

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Pending wake-up events will be cleared and differential data on the bus pins converted to digital data via the low-power receiver and output on pin RXD.

In the TJA1462A, the low-power receiver is supplied from V_{IO} and can detect CAN bus activity when V_{IO} is above $V_{uvd(swoff)(VIO)}$ (even if V_{IO} is the only available supply voltage).

7.1.3 Normal mode

A LOW level on pin STB selects Normal mode, provided the supply voltage on pin VCC is above the standby undervoltage detection threshold, $V_{uvd(stb)(VCC)}$.

In this mode, the transceiver can transmit and receive data via bus lines CANH and CANL. Pin TXD must be HIGH at least once in Normal Mode before transmission can begin. The differential receiver converts the analog data on the bus lines into digital data on pin RXD. The slopes of the output signals on the bus lines are controlled internally and are optimized in a way that guarantees the lowest possible EME. In order to support high bit rates, especially in CAN FD systems, the Signal Improvement function largely eliminates topology-related reflections and impedance mismatches. In recessive state, the output voltage on the bus pins is $V_{CC}/2$.

7.1.4 Operating modes and gap-free operation

Gap-free operation guarantees defined behavior at all voltage levels. Supply voltage-tooperating mode mapping is detailed in <u>Figure 5</u> and in the state diagrams (<u>Figure 3</u> and <u>Figure 4</u>).

	TJA1462A						TJA1462B	
	5.5 V - 6 V ^[1]			Fully functiona	[2][3]		5.5 V - 6 V ^[1]	Fully functional ^{[2][3]}
e on VCC	V _{CC} operating range (4.5 V - 5.5 V)		Fully functional ^{[2][3]} or Off ^[4]	Fully functional ^[2] and characteristics guaranteed ^[5]		e on VCC	V _{CC} operating range (4.5 V - 5.5 V)	Fully functional ^[2] and characteristics guaranteed ^[5]
Voltage range on VCC	V _{uvd(stb)(VCC)} range ^[6]	Off	Fully functional ^[2] or Standby or Off ^[4]	Fully functional ^[2] or Standby ^[4]		Voltage range on VCC	V _{uvd(stb)(VCC)} range	Fully functional ^[2] or Standby ^[4]
Volta						Volta	2.95 V - 4 V	Standby
	-0.3 V - 4 V		Standby or Off ^[4]	Standby			V _{uvd(swoff)(VCC)} range	Standby or Off ^[4]
							-0.3 V - 2.65 V	Off
		-0.3 V - 2.65 V	Vuvd(swoff)(VIO) range ^[6]	V _{IO} operating range (2.95 V - 5.5 V)	5.5 V - 6 V[1]			
			Voltage ra	nge on VIO				
[2] [3] [4]	characteristics, function functionality cannot be Target transceiver func Prolonged operation of characteristics are gua For a given value of V _C thresholds (V _{uv4(stb)} (v _C in this data sheet). To g minimum thresholds sp Datasheet characterist characteristics tables. The following applies to - If both V _{CC} and V _{IO} a - If V _{CC} is below and V	nality of guara tionali the de rantee C (and CC), Vu uaran ecified ics are o TJA1 ire abo	pr performance may occunteed. ty as described in this date over the operation of the operation of the AMR has V_{IO} in TJA1462A), a spectra of the device will be in a different of these undervoltage of guaranteed within the Value the undervoltage three three the undervoltage three three the undervoltage three three the undervoltage three thre	r. Returning from above A tasheet is applicable. Ig range may impact reliat not been exceeded. scific device will be in a sir voff(VCC)). The actual thre is specific state, V _{IO} and V ₀ detection ranges.	MR to bility ov gle de sholds CC mus ges. Ex unction ndby m	the op ver life fined s can v st be e cceptic nal. node.	table). Above the AMR, ir perating range, datasheet time. Returning to the oper state determined by its unc rary between devices (with ither above the maximum ons are described in the St	characteristics and rating range, datasheet lervoltage detection in the ranges specified or below the
								aaa-037309
Figu	re 5. Supply voltag	ge ra	nges and gap-free	operation				
	7.2	Ren	note wake-up	(via the CAN b	us)			
			TJA1462 wakes u cified in ISO 11898				a dedicated wake-	up pattern

The wake-up pattern consists of:

- a dominant phase of at least $\underline{t}_{\underline{wake}(\underline{busdom})}$ followed by
- a recessive phase of at least $\underline{t_{wake(busrec)}}$ followed by
- a dominant phase of at least twake(busdom)

Dominant or recessive bits between the above mentioned phases that are shorter than $t_{wake(busdom)}$ and $t_{wake(busrec)}$ respectively are ignored.

The complete dominant-recessive-dominant pattern must be received within $\underline{t_{to(wake)bus}}$ to be recognized as a valid wake-up pattern (see <u>Figure 6</u>). Otherwise, the internal wake-up

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logic is reset. The complete wake-up pattern then needs to be retransmitted to trigger a wake-up event. Pin RXD remains HIGH until the wake-up event has been triggered.

After a wake-up sequence has been detected, the TJA1462 remains in Standby mode with the bus signals reflected on RXD after $\underline{t_{startup(RXD)}}$. Note that dominant or recessive phases lasting less than $\underline{t_{fitr(wake)bus}}$ will not be detected by the low-power differential receiver and will not be reflected on RXD in Standby mode.

A wake-up event is not flagged on RXD if any of the following events occurs while a valid wake-up pattern is being received:

- · The device switches to Normal mode
- The complete wake-up pattern was not received within tto(wake)bus
- A V_{CC} or V_{IO} switch-off undervoltage is detected (V_{CC} < V_{uvd(swoff)(VCC)} or V_{IO} < $V_{uvd(swoff)(VIO)}$; see Section 7.3.3)

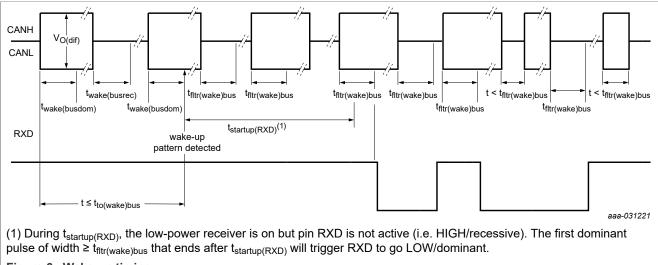


Figure 6. Wake-up timing

7.3 Fail-safe features

7.3.1 TXD dominant time-out function

A 'TXD dominant time-out' timer is started when pin TXD is set LOW. If the LOW state on this pin persists for longer than $\underline{t_{to(dom)TXD}}$, the transmitter is disabled, releasing the bus lines to recessive state. This function prevents a hardware and/or software application failure from driving the bus lines to a permanent dominant state (blocking all network communications). The TXD dominant time-out timer is reset when pin TXD goes HIGH.

7.3.2 Internal biasing of TXD and STB input pins

Pins TXD and STB have internal pull-ups to V_{CC}/V_{IO} to ensure a safe, defined state in case one, or both, of these pins is left or becomes floating. Pull-up resistors are active on these pins in all states; they should be held at the V_{CC}/V_{IO} level in Standby mode to minimize supply current.

7.3.3 Undervoltage detection on pins VCC and VIO

If V_{CC} drops below the standby undervoltage detection threshold (V_{uvd(stb)(VCC)}) for $t_{det(uv)}$, the transceiver switches to Standby mode. The logic state of pin STB is ignored until V_{CC} has recovered.

In the TJA1462A, if V_{IO} drops below the switch-off undervoltage detection threshold $(V_{uvd(swoff)(VIO)})$ for $t_{uvd(swoff)}$, the transceiver switches to Off mode and disengages from the bus (high-ohmic) until V_{IO} has recovered.

In the TJA1462B, if V_{CC} drops below the switch-off undervoltage detection threshold $(V_{uvd(swoff)(VCC)})$ for $t_{uvd(swoff)}$, the transceiver switches to Off mode and disengages from the bus (high-ohmic) until V_{CC} has recovered.

7.3.4 Overtemperature protection

The device is protected against overtemperature conditions. If the junction temperature exceeds the shutdown junction temperature, $T_{j(sd)}$, the CAN bus drivers are disabled. When the junction temperature drops below $T_{j(sd)rel}$, the CAN bus drivers recover once TXD has been reset to HIGH and Normal mode is selected (waiting for TXD to go HIGH prevents output driver oscillation due to small variations in temperature).

7.3.5 I/O levels

Pin VIO on the TJA1462A should be connected to the microcontroller supply voltage (see Figure 12). This adjusts the signal levels on pins TXD, RXD and STB to the I/O levels of the microcontroller, allowing for direct interfacing without additional glue logic. Pin VIO also provides the internal supply voltage for the low-power differential receiver. For applications running in low-power mode, this allows the bus lines to be monitored for activity even if there is no supply voltage on pin VCC.

All I/O levels are related to V_{CC} in the TJA1462B and are, therefore, compatible with 5 V microcontrollers. Spurious signals from the microcontroller on pin STB are filtered out with a filter time of $\underline{t_{fltr(IO)}}$.

Limiting values 8

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). All voltages are referenced to GND, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Max	Unit
V _x	voltage on pin x ^[1]	pins VCC, VIO (TJA1462A), TXD, STB		-0.3	+6	V
				-	+7 ^[2]	V
		pins CANH, CANL		-36	+40	V
		pin RXD				
		TJA1462A		-0.3	V _{IO} +0.3 ^[3]	V
		TJA1462B		-0.3	V _{CC} +0.3 ^[3]	V
V _(CANH-CANL)	voltage between pin CANH and pin CANL			-40	+40	V
V _{trt}	transient voltage	on pins CANH, CANL	[4]			
		pulse 1		-100	-	V
		pulse 2a		-	+75	V
		pulse 3a		-150	-	V
		pulse 3b		-	+100	V
V _{ESD}	electrostatic discharge	IEC 61000-4-2 (150 pF, 330 Ω discharge circuit)	[5]			
	voltage	on pins CANH, CANL		-6	+6	kV
		Human Body Model (HBM)				
		on any pin	[6]	-4	+4	kV
		on pins CANH, CANL	[7]	-8	+8	kV
		Charged Device Model (CDM)	[8]			
		on corner pins		-750	+750	V
		on any other pin		-500	+500	V
T _{vj}	virtual junction temperature		[9]	-40	+150	°C
T _{stg}	storage temperature		[10]	-55	+150	°C

The device can sustain voltages up to the specified values over the product lifetime, provided applied voltages (including transients) never exceed these [1] values.

[2] [3]

The device can withstand voltages between 6 V and 7 V for a total of 20 s over the product lifetime. Subject to the qualifications detailed in Table notes 1 and 2 above for pins VCC, VIO, TXD and STB. Verified by an external test house according to IEC TS 62228, Section 4.2.4; parameters for standard pulses defined in ISO7637. Verified by an external test house according to IEC TS 62228, Section 4.3. [4]

[5]

According to AEC-Q100-002. [6]

Pins stressed to reference group containing all ground and supply pins, emulating the application circuits (Figure 12 and Figure 13). HBM pulse as [7] specified in AEC-Q100-002 used.

According to AEC-Q100-011. [8]

[9] In accordance with IEC 60747-1. An alternative definition of virtual junction temperature is: $T_{vj} = T_{amb} + P \times R_{th(j-a)}$, where $R_{th(j-a)}$ is a fixed value used in the calculation of T_{vj} . The rating for T_{vj} limits the allowable combinations of power dissipation (P) and ambient temperature (T_{amb}). [10] T_{stg} in application according to IEC61360-4. For component transport and storage conditions, see instead IEC61760-2.

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9 Thermal characteristics

Table 7. Thermal characteristics

Value determined for free convection conditions on a JEDEC 2S2P board.

Symbol	Parameter	Conditions ^[1]	Тур	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	SO8	100	K/W
		HVSON8	60	K/W
R _{th(j-c)}	thermal resistance from junction to case ^[2]	HVSON8	22	K/W
Ψ_{j-top}	thermal characterization parameter from junction to top of package	SO8	17	K/W
		HVSON8	16	K/W

[1] According to JEDEC JESD51-2, JESD51-5 and JESD51-7 at natural convection on 2s2p board. Board with two inner copper layers (thickness: 35 µm) and thermal via array under the exposed pad connected to the first inner copper layer (thickness: 70 µm).

[2] Case temperature refers to the center of the heatsink at the bottom of the package.

10 Static characteristics

Table 8. Static characteristics

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJA1462A); R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
Supply; pin	VCC]
V _{CC}	supply voltage		4.5	-	5.5	V
V _{uvd(stb)}	standby undervoltage detection voltage	[2] 4	-	4.5	V
V _{uvhys(stb)}	standby undervoltage hysteresis voltage		50	-	-	mV
V _{uvd(swoff)}	switch-off undervoltage detection voltage	TJA1462B ^{[2}	2.65	-	2.95	V
I _{CC}	supply current	Normal mode				
		dominant; V _{TXD} = 0 V; t < t _{to(dom)TXD}	-	42	70	mA
		dominant; V _{TXD} = 0 V; short circuit on bus lines; -3 V < (V _{CANH} = V _{CANL}) < +40 V	-	-	125	mA
		recessive; $V_{TXD} = V_{IO}^{[3]}$	-	7	10	mA
		Standby mode				
		TJA1462A; T _{vj} < 85 °C	-	-	2	μA
		TJA1462B; T _{vj} < 85 °C	-	8	21	μA
I/O level ada	apter supply; pin VIO (TJA1462	2A)				
V _{IO}	supply voltage		2.95	-	5.5	V
V _{uvd(swoff)}	switch-off undervoltage detection voltage	[2	2.65	-	2.95	V
I _{IO}	supply current	Normal mode, dominant; V _{TXD} = 0 V	-	250	760	μA
		Normal mode, recessive; $V_{TXD} = V_{IO}$	-	150	460	μA

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Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJA1462A); R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
		Standby mode; T _{vj} < 85 °C		-	8	19	μA
CAN transm	nit data input; pin TXD	'					
V _{IH}	HIGH-level input voltage			0.7V _{IO} ^[3]	-	-	V
V _{IL}	LOW-level input voltage			-	-	0.3V _{IO} ^[3]	V
V _{hys(TXD)}	hysteresis voltage on pin TXD			50	-	-	mV
R _{pu}	pull-up resistance			20	-	80	kΩ
Ci	input capacitance		[4]	-	-	10	pF
CAN receive	e data output; pin RXD					1	
I _{OH}	HIGH-level output current	$V_{RXD} = V_{IO}^{[3]} - 0.4 V$		-10	-	-1	mA
I _{OL}	LOW-level output current	V _{RXD} = 0.4 V; bus dominant		1	-	10	mA
Standby cor	ntrol input; pin STB	·					
V _{IH}	HIGH-level input voltage			0.7V _{IO} ^[3]	-	-	V
V _{IL}	LOW-level input voltage			-	-	0.3V _{IO} ^[3]	V
V _{hys}	hysteresis voltage			50	-	-	mV
R _{pu}	pull-up resistance			20	-	80	kΩ
Ci	input capacitance		[4]	-	-	10	pF
Bus lines; p	ins CANH and CANL	1			1		
V _{O(dom)}	dominant output voltage	V_{TXD} = 0 V; t < $t_{to(dom)TXD}$; V _{CC} = 4.75 V to 5.25 V					
		pin CANH; R_L = 50 Ω to 65 Ω		2.89	3.5	4.26	V
		pin CANL; $R_L = 50 \Omega$ to 65 Ω		0.77	1.5	2.13	V
V _{TXsym}	transmitter voltage symmetry	V X e v m = V (A N H + V (A N H)	[4] [5]	0.9V _{CC}	-	1.1V _{CC}	V
V _{cm(step)}	common mode voltage step		[4] [5] [6]	-150	-	+150	mV
V _{cm(p-p)}	peak-to-peak common mode voltage		[4] [5] [6]	-300	-	+300	mV
V _{O(dif)}	differential output voltage	dominant; Normal mode; V_{TXD} = 0 V; t < $t_{to(dom)TXD}$; V_{CC} = 4.75 V to 5.25 V					
		R_L = 50 Ω to 65 Ω		1.5	-	2.75	V
		R_L = 45 Ω to 70 Ω		1.4	-	3.3	V
		R _L = 2240 Ω	[4]	1.5	-	5	V
		recessive; no load					
		Normal mode; V _{TXD} = V _{IO} ^[3]		-50	-	+50	mV

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Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJA1462A); R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
		Standby mode	-0.2	-	+0.2	V
V _{O(rec)}	recessive output voltage	Normal mode; V _{TXD} = V _{IO} ^[3] ; no load	2	2.5	3	V
		Standby mode; no load	-0.1	-	+0.1	V
$V_{th(RX)dif}$	differential receiver threshold voltage	$\begin{array}{l} -12 \ V \leq V_{CANH} \leq +12 \ V; \\ -12 \ V \leq V_{CANL} \leq +12 \ V \end{array}$				
		Normal mode	0.5	-	0.9	V
		Standby mode	0.4	-	1.1	V
V _{rec(RX)}	receiver recessive voltage	$\begin{array}{l} -12 \ V \leq V_{CANH} \leq +12 \ V; \\ -12 \ V \leq V_{CANL} \leq +12 \ V \end{array}$				
		Normal mode	-4	-	+0.5	V
		Standby mode	-4	-	+0.4	V
V _{dom(RX)}	receiver dominant voltage	$\begin{array}{l} -12 \ V \leq V_{CANH} \leq +12 \ V; \\ -12 \ V \leq V_{CANL} \leq +12 \ V \end{array}$				
		Normal mode	0.9	-	9	V
		Standby mode	1.1	-	9	V
V _{hys(RX)dif}	differential receiver hysteresis voltage	-12 V \leq V _{CANH} \leq +12 V; -12 V \leq V _{CANL} \leq +12 V; Normal mode	100	-	-	mV
I _{O(sc)}	short-circuit output current	$\begin{array}{l} -15 \ V \leq V_{CANH} \leq +40 \ V; \\ -15 \ V \leq V_{CANL} \leq +40 \ V \end{array}$	-	-	115	mA
I _{O(sc)} rec	recessive short-circuit output current	$\begin{array}{l} -27 \ V \leq V_{CANH} \leq +32 \ V; \\ -27 \ V \leq V_{CANL} \leq +32 \ V; \ Normal \ mode; \\ V_{TXD} = V_{IO}^{[3]} \ for \ t > t_{d(TXD-busrec)end}^{[7]} \end{array}$	-3	-	+3	mA
IL	leakage current	$V_{CC} = V_{IO} = 0$ V or pins shorted to GND via 47 K Ω ; $V_{CANH} = V_{CANL} = 5$ V	-10	-	+10	μA
R _i	input resistance	$\begin{array}{l} -2 \ V \leq V_{CANL} \leq +7 \ V; \\ -2 \ V \leq V_{CANH} \leq +7 \ V \end{array}$	25	40	50	kΩ
ΔR _i	input resistance deviation	$0 \text{ V} \leq \text{V}_{\text{CANL}} \leq +5 \text{ V}; 0 \text{ V} \leq \text{V}_{\text{CANH}} \leq +5 \text{ V}$	-3	-	+3	%
R _{i(dif)}	differential input resistance	$\begin{array}{l} -2 \ V \leq V_{CANL} \leq +7 \ V; \\ -2 \ V \leq V_{CANH} \leq +7 \ V \end{array}$	50	80	100	kΩ
C _{i(cm)}	common-mode input capacitance	[4]	-	-	30	pF
C _{i(dif)}	differential input capacitance	[4]	-	-	15	pF
Signal Impro	ovement function on CANH or CA	NL; +4.75 V ≤ V _{CC} ≤ +5.25 V; see <u>Figure 10</u>	and Fig	<u>gure 11</u>		
R _{i(dom)}	dominant phase input resistancebus dominant; V_{CC} - 1.6 V $\leq V_{CANH} \leq V_{CC}$ - 1.2 V;		-	-	30	Ω
R _{i(dif)dom}	dominant phase differential input resistance	+1.2 V \leq V _{CANL} \leq +1.6 V; R _{i(dif)dom} = R _{i(dom)CANH} + R _{i(dom)CANL}	-	-	60	Ω

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Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJA1462A); R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
R _{i(extdom)}	extended dominant phase input resistance ^[8]	bus dominant-to-recessive transition; +2.3 V \leq V _{CANH} \leq V _{CC} -2.3 V;	-	-	25	Ω
R _{i(dif)extdom}	extended dominant phase differential input resistance ^[8]	+2.3 V \leq V _{CANL} \leq V _{CC} - 2.3 V; R _{i(dif)extdom} = R _{i(extdom)CANH} + R _{i(extdom)CANL}	-	-	50	Ω
R _{i(actrec)}	active recessive phase input resistance ^[8]	+1.5 V ≤ V _{CANH} ≤ V _{CC} - 1.5 V;	37.5	-	62.5	Ω
R _{i(dif)actrec}	active recessive phase differential input resistance ^[8]	+1.5 V \leq V _{CANL} \leq V _{CC} - 1.5 V; R _{i(dif)actrec} = R _{i(actrec)CANH} + R _{i(actrec)CANL}	75	-	125	Ω
Temperature	detection					
T _{j(sd)}	shutdown junction temperature	[4]	180	-	200	°C
T _{j(sd)rel}	release shutdown junction temperature	[4]	175	-	195	°C

[1] All parameters are guaranteed over the junction temperature range by design. Factory testing uses correlated test conditions to cover the specified temperature and power supply voltage range.

[2] Undervoltage is detected between min and max values. Undervoltage is guaranteed to be detected below min value and guaranteed not to be detected above max value.

[3] V_{CC} in TJA1462B

[4] Not tested in production; guaranteed by design.

The test circuit used to measure the bus output voltage symmetry and the common-mode voltages (which includes C_{SPLIT}) is shown in <u>Figure 15</u>.
 See <u>Figure 9</u>

This parameter is defined in CiA specification CiA 601-4:2019 as t_{SIC_TX_base} and is specified in the Dynamic Characteristics table (see <u>Table 9</u> and <u>Figure 10</u>).

 [8] Extended dominant and active recessive phases are not DC states and are only valid for a limited time after a dominant-to-recessive transition on pin TXD.

11 Dynamic characteristics

Table 9. Dynamic characteristics

 $T_{vj} = -40$ °C to +150 °C; $V_{CC} = 4.5$ V to 5.5 V; $V_{IO} = 2.95$ V to 5.5 V (TJA1462A); $R_L = 60 \Omega$ unless specified otherwise; all voltages are defined with respect to ground.^[1]

Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
CAN timing cl <u>Figure 14</u>	haracteristics; V_{CC} = 4.75 V to 5.25 V; $t_{bit(TXD)}$	≥ 125 ns; see <u>Figure 7</u> , <u>Figure 8</u>	<u> 8, Fi</u>	gure 1(), <mark>Figur</mark>	<u>e 11</u> and	ł
t _{d(TXD-busdom)}	delay time from TXD to bus dominant	Normal mode		-	-	80	ns
t _{d(TXD-busrec)}	delay time from TXD to bus recessive	Normal mode		-	-	80	ns
t _{d(busdom-RXD)}	delay time from bus dominant to RXD	Normal mode		-	-	110	ns
t _{d(busrec-RXD)}	delay time from bus recessive to RXD	Normal mode		-	-	110	ns
t _{d(TXDL-RXDL)}	delay time from TXD LOW to RXD LOW	Normal mode		-	-	190	ns
		Normal mode; V_{CC} = 4.5 V to 5.5 V		-	-	255	ns
t _{d(TXDH-RXDH)}	delay time from TXD HIGH to RXD HIGH	Normal mode		-	-	190	ns
		Normal mode; V _{CC} = 4.5 V to 5.5 V		-	-	255	ns
t _{d(TXD-} busrec)end	delay time from TXD to bus recessive end	Normal mode	[2] [3]	415	-	530	ns
t _{d(TXD-} busdom)end	delay time from TXD to bus dominant end	Normal mode	[2]	-	-	115	ns
t _{d(TXD-} extbusdom)end	delay time from TXD to extended bus dominant end	Normal mode	[2]	55	-	-	ns
t _{d(TXD-} busactrec)start	delay time from TXD to bus active recessive start	Normal mode	[2]	70	-	120	ns
t _{d(TXD-} busactrec)end	delay time from TXD to active recessive end	Normal mode	[2]	335	-	480	ns
CAN FD timin Figure 14 ^[4]	g characteristics according to CiA 601-4:201	$P; V_{CC} = 4.75 V \text{ to } 5.25 V; t_{bit(TXC)}$	₀₎ ≥ 1	125 ns;	see Fig	g <mark>ure 8</mark> a	nd
∆t _{bit(bus)}	transmitted recessive bit width deviation	$\Delta t_{bit(bus)} = t_{bit(bus)} - t_{bit(TXD)}$		-10	-	+10	ns
∆t _{rec}	receiver timing symmetry	$\Delta t_{rec} = t_{bit(RXD)} - t_{bit(bus)}$		-20	-	+15	ns
∆t _{bit(RXD)}	received recessive bit width deviation	$\Delta t_{bit(RXD)} = t_{bit(RXD)} - t_{bit(TXD)}$		-30	-	+20	ns
CAN FD timin	g characteristics according to ISO 11898-2:20	016 ^[5] ; V _{CC} = 4.75 V to 5.25 V; se	ee <mark>F</mark>	igure 8	and Fi	gure 14	[4]
t _{bit(bus)} [6]	transmitted recessive bit width	2 Mbit/s (t _{bit(TXD)} = 500 ns)					
		V _{CC} = 4.75 V to 5.25 V		490	-	510	ns
		V _{CC} = 4.5 V to 5.5 V		435	-	530	ns
		5 Mbit/s (t _{bit(TXD)} = 200 ns)					
		$V_{\rm CC} = 4.75 \text{ V to } 5.25 \text{ V}$		190	-	210	ns
		V _{CC} = 4.5 V to 5.5 V	[7]	170	-	230	ns
		8 Mbit/s (t _{bit(TXD)} = 125 ns)					
		$V_{\rm CC} = 4.75 \text{ V to } 5.25 \text{ V}$		115	-	135	ns
		~~					

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Table 9. Dynamic characteristics...continued

 $T_{vj} = -40 \text{ °C}$ to +150 °C; $V_{CC} = 4.5 \text{ V}$ to 5.5 V; $V_{IO} = 2.95 \text{ V}$ to 5.5 V (TJA1462A); $R_L = 60 \Omega$ unless specified otherwise; all voltages are defined with respect to ground.^[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
∆t _{rec}	receiver timing symmetry	V_{CC} = 4.75 V to 5.25 V; for 2 Mbit/s, 5 Mbit/s and 8 Mbit/s		-20	-	+15	ns
		V _{CC} = 4.5 V to 5.5 V; 2 MBit/s		-65	-	+40	ns
		V_{CC} = 4.5 V to 5.5 V; 5 Mbit/s		-45	-	+15	ns
t _{bit(RXD)} ^[8]	bit time on pin RXD	2 Mbit/s (t _{bit(TXD)} = 500 ns)					
		V_{CC} = 4.75 V to 5.25 V		470	-	520	ns
		V_{CC} = 4.5 V to 5.5 V		400	-	550	ns
		5 Mbit/s (t _{bit(TXD)} = 200 ns)					
		V_{CC} = 4.75 V to 5.25 V		170	-	220	ns
		V_{CC} = 4.5 V to 5.5 V	[7]	150	-	240	ns
		8 Mbit/s (t _{bit(TXD)} = 125 ns)					
		V _{CC} = 4.75 V to 5.25 V		95	-	145	ns
Dominant tim	ne-out time; pin TXD						
<u>t_{to(dom)}TXD</u>	TXD dominant time-out time	V _{TXD} = 0 V; Normal mode	[2] [9]	0.8	-	9	ms
Bus wake-up	times; pins CANH and CANL; see Figure 6	<u>3</u>			1		
<u>twake(busdom)</u>	bus dominant wake-up time	Standby mode	[2] [10]	0.5	-	1.8	μs
<u>t_{wake(busrec)}</u>	bus recessive wake-up time		[2] [10]	0.5	-	1.8	μs
<u>t_{to(wake)bus}</u>	bus wake-up time-out time	Standby mode	[2] [9]	0.8	-	9	ms
<u>t fltr(wake)bus</u>	bus wake-up filter time	Standby mode	[2]	-	-	1.8	μs
Mode transiti	ons						
<u>t_{t(moch)}</u>	mode change transition time		[2]	-	-	50	μs
<u>t_{startup}</u>	start-up time		[2]	-	-	1.5	ms
<u>t_{startup(RXD)}</u>	RXD start-up time	after wake-up detected	[2] [11]	4	-	20	μs
IO filter; pin S	STB					1	
<u>t_{fltr(IO)}</u>	IO filter time	[[12]	1	-	5	μs
Undervoltage	e detection; Figure 3 and Figure 4						
t _{det(uv)}	undervoltage detection time	on pin VCC	[2]	-	-	30	μs
t _{uvd(swoff)}	switch-off undervoltage detection time	on pin VCC; TJA1462B	[2]	-	-	30	μs
		on pin VIO; TJA1462A	[2]			30	μs
t _{rec(uv)}	undervoltage recovery time	on pin VCC	[2]	-	-	50	μs
					1		

All parameters are guaranteed over the junction temperature range by design. Factory testing uses correlated test conditions to cover the specified [1] temperature and power supply voltage range. Not tested in production; guaranteed by design.

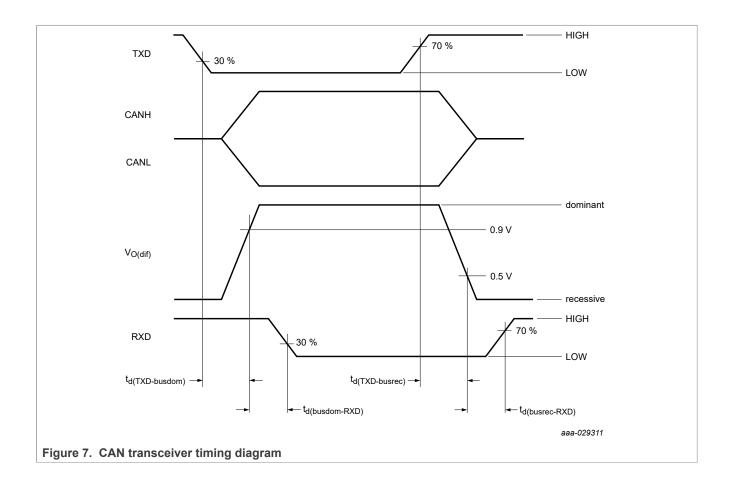
[2]

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- If TXD goes LOW before the recessive transition has been completed, the bus switches to dominant. [3]
- TJA1462 fully meets CiA 601-4:2019 which sets tighter limits for tbit(bus), Δt_{rec} and $\Delta t_{bit(RXD)}$ than ISO 11898-2:2016, which TJA1462 therefore also fully [4] meets
- 8 Mbit/s specification extends the timing characteristics of ISO 11898-2:2016 and CiA 601-4:2019. [5]
- [6]
- $t_{bit(bus)} = \Delta t_{bit(TXD)}$. For reasons related to CAN FD bit timing symmetry, these values are centered around the nominal bit length. Details can be found in document AH2002 [7] 'TJx144x/TJx146x Application Hints', available on request from NXP Semiconductors.
- [8]
- $t_{\text{bit}(RXD)} = \Delta t_{\text{bit}(RXD)} + t_{\text{bit}(TXD)}$. Time-out occurs between the min and max values. Time-out is guaranteed not to occur below the min value; time-out is guaranteed to occur above the [9] max value.
- [10] A dominant/recessive phase shorter than the min value is guaranteed not be seen as a dominant/recessive bit; a dominant/recessive phase longer than the max value is guaranteed to be seen as a dominant/recessive bit.
- [11] When a wake-up is detected, RXD start-up time is between the min and max values. RXD cannot be relied on below the min value; RXD can be relied on above the max value; see Figure 6.
- [12] Pulses shorter than the min value are guaranteed to be filtered out; pulses longer than the max value are guaranteed to be processed.

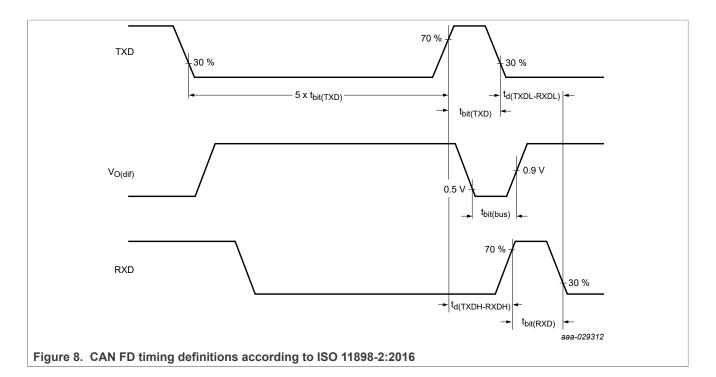


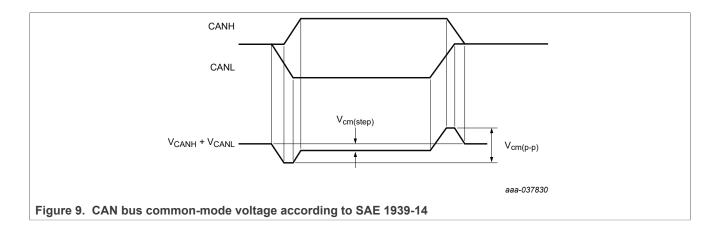
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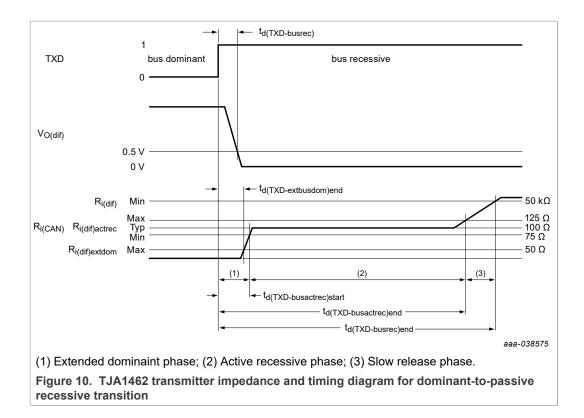
NXP Semiconductors

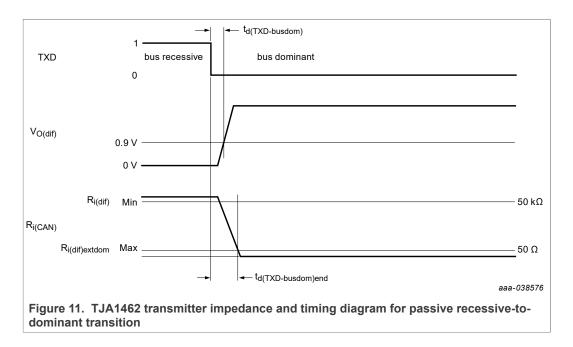
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CAN FD signal improvement transceiver with Standby mode



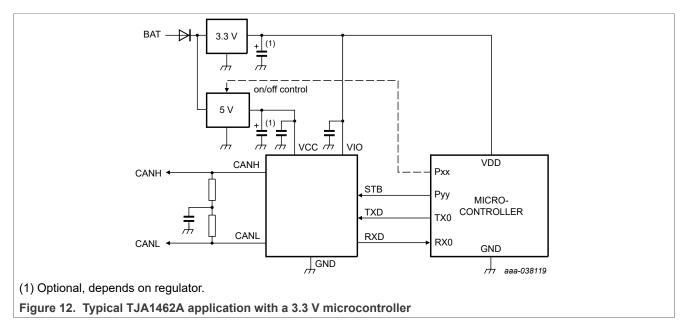


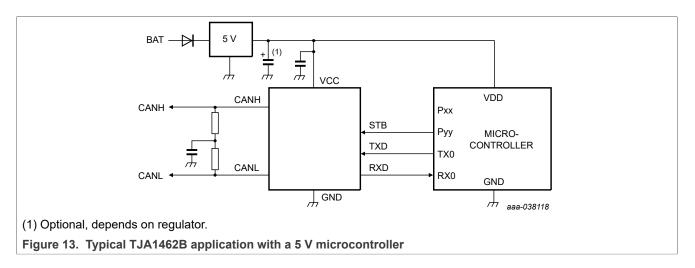




12 Application information

12.1 Application diagrams

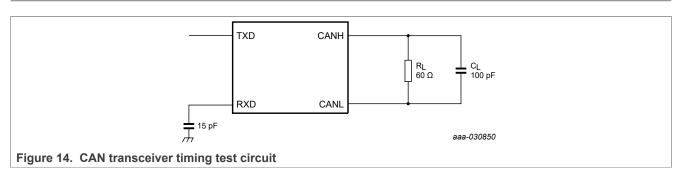


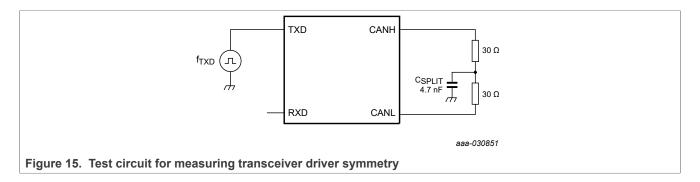


12.2 Application hints

Further information on the application of the TJA1462 can be found in NXP application hints AH2002 '*TJx144x/TJx146x Application Hints*', available on request from NXP Semiconductors.

13 Test information





13.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q100 Rev-H - Failure mechanism based stress test qualification for integrated circuits*, and is suitable for use in automotive applications.

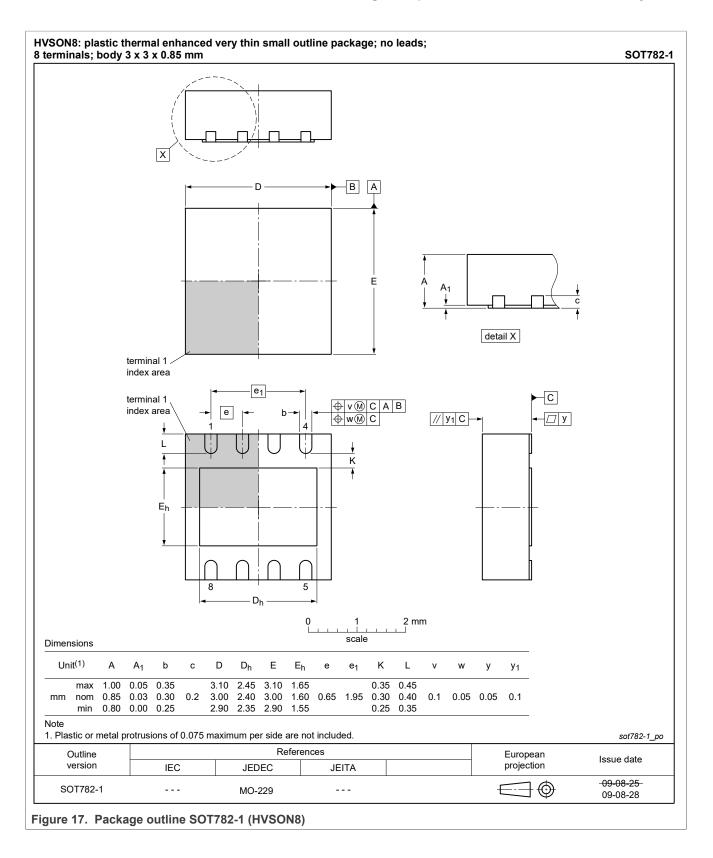
14 Package outline

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UNIT	A max.	A ₁	A ₂	A ₃	b _p 0.49 0.36 0.019	с	D ⁽¹⁾	E ⁽²⁾								0.1 0.004	0.7 0.3 0.028 0.012	8° 0°
UNIT mm inches Notes	A max. 1.75 0.069	A ₁ 0.25 0.10 0.010 0.004	A ₂ 1.45 1.25 0.057 0.049 sions of	A ₃ 0.25 0.01	b _p 0.49 0.36 0.019 0.014 m (0.00	c 0.25 0.19 0.0100	D ⁽¹⁾ 5.0 4.8 0.20 0.19	E ⁽²⁾ 4.0 3.8 0.16 0.15	1.27 0.05	6.2 5.8 0.244 0.228	1.05 0.041	1.0 0.4 0.039	0.7 0.6 0.028	0.25	0.25		0.3	8° 0°
UNIT mm inches Notes I. Plastic 2. Plastic	A max. 1.75 0.069	A ₁ 0.25 0.10 0.010 0.004	A ₂ 1.45 1.25 0.057 0.049 sions of	A ₃ 0.25 0.01	b _p 0.49 0.36 0.019 0.014 m (0.00	c 0.25 0.19 0.0100 0.0075 6 inch) m	D ⁽¹⁾ 5.0 4.8 0.20 0.19 aximum	E ⁽²⁾ 4.0 3.8 0.16 0.15	1.27 0.05 le are no	6.2 5.8 0.244 0.228	1.05 0.041	1.0 0.4 0.039	0.7 0.6 0.028	0.25	0.25 0.01 PEAN	0.004	0.3	0°
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CAN FD signal improvement transceiver with Standby mode



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Product data sheet

15 Handling information

All input and output pins are protected against ElectroStatic Discharge (ESD) under normal handling. When handling ensure that the appropriate precautions are taken as described in *JESD625-A* or equivalent standards.

16 Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow soldering description"*.

16.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

16.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- Board specifications, including the board finish, solder masks and vias
- Package footprints, including solder thieves and orientation
- · The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- · Lead-free soldering versus SnPb soldering

16.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- · Solder bath specifications, including temperature and impurities

16.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 18</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with <u>Table 10</u> and <u>Table 11</u>

Table 10. SnPb eutectic process (from J-STD-020D)

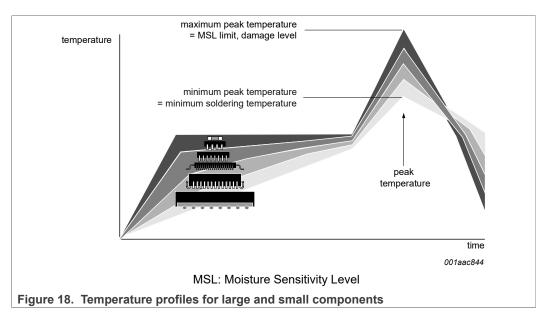
Package thickness (mm)	Package reflow temperature (°C) Volume (mm³)							
	< 350	≥ 350						
< 2.5	235	220						
≥ 2.5	220	220						

Table 11. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)								
	Volume (mm ³)								
	< 350	350 to 2000	> 2000						
< 1.6	260	260	260						
1.6 to 2.5	260	250	245						
> 2.5	250	245	245						

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see <u>Figure 18</u>.



For further information on temperature profiles, refer to Application Note *AN10365 "Surface mount reflow soldering description"*.

17 Soldering of HVSON packages

<u>Section 16</u> contains a brief introduction to the techniques most commonly used to solder Surface Mounted Devices (SMD). A more detailed discussion on soldering HVSON leadless package ICs can be found in the following application note:

• AN10365 "Surface mount reflow soldering description"

18 Appendix: ISO 11898-2:2016 and CiA 601-4:2019 parameter crossreference lists

ISO 11898-2:2016		NXP data she	eet
Parameter	Notation	Symbol	Parameter
HS-PMA dominant output characteristics			
Single ended voltage on CAN_H	V _{CAN_H}	V _{O(dom)}	dominant output voltage
Single ended voltage on CAN_L	V _{CAN_L}		
Differential voltage on normal bus load	V _{Diff}	V _{O(dif)}	differential output voltage
Differential voltage on effective resistance during arbitration			
Optional: Differential voltage on extended bus load range	-		
HS-PMA driver symmetry	1		
Driver symmetry	V _{SYM}	V _{TXsym}	transmitter voltage symmetry
Maximum HS-PMA driver output current			
Absolute current on CAN_H	I _{CAN_H}	I _{O(sc)}	short-circuit output current
Absolute current on CAN_L	I _{CAN_L}		
HS-PMA recessive output characteristics, bus biasing ac	tive/inacti	ve	
Single ended output voltage on CAN_H	V _{CAN_H}	V _{O(rec)}	recessive output voltage
Single ended output voltage on CAN_L	V _{CAN_L}	_	
Differential output voltage	V _{Diff}	V _{O(dif)}	differential output voltage
Optional HS-PMA transmit dominant time-out		1	
Transmit dominant time-out, long	t _{dom}	t _{to(dom)TXD}	TXD dominant time-out time
Transmit dominant time-out, short	-		
HS-PMA static receiver input characteristics, bus biasing	g active/ina	active	
Recessive state differential input voltage range Dominant state differential input voltage range	V _{Diff}	V _{th(RX)dif}	differential receiver threshold voltage
		V _{rec(RX)}	receiver recessive voltage
		V _{dom(RX)}	receiver dominant voltage
HS-PMA receiver input resistance (matching)			
Differential internal resistance	R _{Diff}	R _{i(dif)}	differential input resistance
Single ended internal resistance	R _{CAN_H} R _{CAN_L}	R _i	input resistance
Matching of internal resistance	MR	ΔR _i	input resistance deviation
HS-PMA implementation loop delay requirement			
Loop delay	t _{Loop}	$t_{d(TXDH-RXDH)}$	delay time from TXD HIGH to RXD HIGH
		t _{d(TXDL-RXDL)}	delay time from TXD LOW to RXD LOW

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ISO 11898-2:2016		NXP data she	et		
Parameter	Notation	Symbol	Parameter		
Optional HS-PMA implementation data signal timing requ Mbit/s and above 2 Mbit/s up to 5 Mbit/s	uirements f	for use with bit	rates above 1 Mbit/s up to 2		
Transmitted recessive bit width @ 2 Mbit/s / @ 5 Mbit/s, intended	t _{Bit(Bus)}	t _{bit(bus)}	transmitted recessive bit width		
Received recessive bit width @ 2 Mbit/s / @ 5 Mbit/s	t _{Bit(RXD)}	t _{bit(RXD)}	bit time on pin RXD		
Receiver timing symmetry @ 2 Mbit/s / @ 5 Mbit/s	∆t _{Rec}	∆t _{rec}	receiver timing symmetry		
HS-PMA maximum ratings of $V_{CAN_H},$ V_{CAN_L} and V_{Diff}			, 		
Maximum rating V _{Diff}	V _{Diff}	V _(CANH-CANL)	voltage between pin CANH and pin CANL		
General maximum rating V_{CAN_H} and V_{CAN_L}	V _{CAN_H}	V _x	voltage on pin x		
Optional: Extended maximum rating VCAN_H and VCAN_L	V _{CAN_L}				
HS-PMA maximum leakage currents on CAN_H and CAN	_L, unpow	ered	,		
Leakage current on CAN_H, CAN_L	I _{CAN_H} I _{CAN_L}	IL	leakage current		
HS-PMA bus biasing control timings					
CAN activity filter time, long	t _{Filter}	t _{wake(busdom)} [1]	bus dominant wake-up time		
CAN activity filter time, short		t _{wake(busrec)}	bus recessive wake-up time		
Wake-up time-out, short	t _{Wake}	t _{to(wake)bus}	bus wake-up time-out time		
Wake-up time-out, long					

Table 12. ISO 11898-2:2016 to NXP data sheet parameter conversion...continued

[1] t_{fltr(wake)bus} - bus wake-up filter time, in devices with basic wake-up functionality

Table 13. CiA 601-4:2019 to NXP data sheet parameter conversion

CiA 601-4:2019		NXP data sheet					
Parameter	Notation	Symbol	Parameter				
Optional HS-PMA implementation data signa	I timing require	ments					
Signal improvement time TX-based	t _{SIC_TX_base}	$t_{d(TXD-busrec)end}$	delay time from TXD to bus recessive end				
Signal improvement time RX-based	t _{SIC_RX_base}	N/A ^[1]	N/A				
Transmitted bit width variation	Δt _{Bit(Bus)}	∆t _{bit(bus)}	transmitted recessive bit width deviation				
Received bit width variation	Δt _{Bit(RxD)}	$\Delta t_{bit(RXD)}$	received recessive bit width deviation				
Receiver timing symmetry	Δt_{REC}	Δt_{rec}	receiver timing symmetry				
Propagation delay from TXD to bus dominant	t _{prop(TxD-busdom)}	t _{d(TXD-busdom)}	delay time from TXD to bus dominant				
Propagation delay from TXD to bus recessive	t _{prop(TxD-busrec)}	t _{d(TXD-busrec)}	delay time from TXD to bus recessive				
Propagation delay from bus to RXD dominant	t _{prop(busdom-RXD)}	t _{d(busdom-RXD)}	delay time from bus dominant to RXD				
Propagation delay from bus to RXD recessive	t _{prop(busrec-RXD)}	t _{d(busrec-RXD)}	delay time from bus recessive to RXD				

[1] The NXP signal improvement implementation is TX-based; RX-based is not applicable.

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19 Appendix: TJx144x/TJx146x/TJF1441 family overview

Table 14. Feature overview of the complete TJx144x/TJx146x/TJF1441 family

Mode	s	1			Suppl	lies		Data I	rate	Addit	onal fe	eatures	5		
Normal	Standby	Sleep	Silent/Listen-only	Selectable Off	VCC pin	VIO pin	VBAT pin	Up to 5 Mbit/s CAN FD	Up to 8 Mbit/s CAN FD ^[2]	Signal improvement ^[3]	Wake-up source recognition ^[4]	Short WUP support [0.5 - 1.8 µs] ^[5]	Single supply pin wake-up ^[6]	TXD dominant timeout	Local diagnostics via ERR_N pin
•			•		•	•		•						•	
•			•		•			•						•	
•			•	•	•			•						•	
•			•		•	•		•						[7]	
•	•				•	•		•				•	•	•	
•	•				•			•				•		•	
•	•	•	•		•	•	•	•			•	•	•	•	•
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•	•	•	•		•	•	•	•	•	•	•	•	•	•	•
	Normal • <td>• • • •</td> <td>Normal Normal Standby Standby Standby Standby Standby Standby</td> <td>• •</td> <td>• •</td> <td>• •</td> <td>Normal Normal Normal Normal Standby Sta</td> <td>• •</td> <td>• •</td> <td>• •</td> <td>• •</td> <td>Image: second second</td> <td>• •</td> <td>• • • Normal •<td>Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Standby Normal Standby Normal Standby Normal Standby Normal Standby Normal Standby Normal Normal Normal<</td></td>	• • • •	Normal Normal Standby Standby Standby Standby Standby Standby	• •	• •	• •	Normal Normal Normal Normal Standby Sta	• •	• •	• •	• •	Image: second	• •	• • • Normal • <td>Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Standby Normal Standby Normal Standby Normal Standby Normal Standby Normal Standby Normal Normal Normal<</td>	Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Normal Standby Normal Standby Normal Standby Normal Standby Normal Standby Normal Standby Normal Normal Normal<

TJx: TJA14xxx is AEC-Q100 Grade 1; TJR14xxx is AEC-Q100 Grade 0; TJF1441A is non-automotive grade. Only guaranteed for TJA146x, AEC-Q100 Grade 1. [1]

[2] [3]

CAN FD Signal Improvement Capability (SIC) according to CiA 601-4:2019.

[4] RXD is held LOW after wake-up request, enabling wake-up source recognition.

[5] WUP = wake-up pattern according ISO11898-2:2016.

[6] [7] Only VIO supply needed for wake-up in TJA1442A, TJA1448A, TJA1448C, TJA1462A; only VBAT supply needed for wake-up in TJA1443A, TJA1463A.

Not having TXD dominant timeout allows for very low data rates in non-automotive grade applications.

20 Revision history

Table 15. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes					
TJA1462 v.2	20211015	Product data sheet - TJA1462 v.1							
Modifications	t _{bit(TXD)} , t _{bit(BUS)} • Added device (<u></u> • <u>Table 6</u> : table n • <u>Table 9</u> : measu	rement conditions for par	ed in <u>Table 9</u> and tab ion 19) feature over ameter t _{startup(RXD)} r	ile note 5 added /iews					

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Table 15. Revision history...continued

Document ID	Release date	Data sheet status	Change notice	Supersedes
TJA1462 v.1	20200812	Product data sheet	-	-

21 Legal information

21.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

Please consult the most recently issued document before initiating or completing a design. [1]

[2] [3] The term 'short data sheet' is explained in section "Definitions".

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